

Search Notes

Application/Control No.

10/715,864

Examiner

Christopher S. Kim

Applicant(s)/Patent under
Reexamination

NIES, JUERGEN

Art Unit

3752

SEARCHED

Class	Subclass	Date	Examiner
239	743 744 745 747 748 754 195-198	4/28/2006	CK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR